HIP

	Application No.	Applicant(s)
Notice of Allowability	10/772,241	HEISMANN, BJOERN
	Examiner	Art Unit
	Irakli Kiknadze	2882
The MAILING DATE of this communication apply All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT R of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED or other appropriate comm IGHTS. This application is	n this application. If not included nunication will be mailed in due course. <b>THIS</b>
1. $igstyle$ This communication is responsive to <u>the Examinera Ameri</u>	dment dated 04/18/2005.	
2. X The allowed claim(s) is/are 1-9 and 11.		
3. $\boxtimes$ The drawings filed on <u>06 February 2004</u> are accepted by t	he Examiner.	
<ul> <li>4.  Acknowledgment is made of a claim for foreign priority unally All b)  Some* c)  None of the:</li> <li>1.  Certified copies of the priority documents have</li> <li>2.  Certified copies of the priority documents have</li> </ul>	e been received. e been received in Applicati	on No
3. Copies of the certified copies of the priority documents have been received in this national stage application from the		
International Bureau (PCT Rule 17.2(a)).		
* Certified copies not received:  Applicant has THREE MONTHS FROM THE "MAILING DATE"	of this communication to fil	e a reply complying with the requirements
noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,
5. A SUBSTITUTE OATH OR DECLARATION must be subm INFORMAL PATENT APPLICATION (PTO-152) which giv		
6. CORRECTED DRAWINGS ( as "replacement sheets") must	st be submitted.	
(a) ☐ including changes required by the Notice of Draftspers	-	w ( PTO-948) attached
1)  hereto or 2)  to Paper No./Mail Date		
(b) ☐ including changes required by the attached Examiner' Paper No./Mail Date	s Amendment / Comment o	or in the Office action of
Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in t		
7. DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT		
Attachment(s)		
1. Notice of References Cited (PTO-892)		nformal Patent Application (PTO-152)
2. Notice of Draftperson's Patent Drawing Review (PTO-948)		Summary (PTO-413), ./Mail Date
3. ☑ Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 2/6/04; 7/6/04	08), 7. ⊠ Examiner's	s Amendment/Comment
4.   Examiner's Comment Regarding Requirement for Deposit		s Statement of Reasons for Allowance
of Biological Material	9. 🔲 Other	·
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## **DETAILED ACTION**

## **EXAMINER'S AMENDMENT**

- 1. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.
- 2. Authorization for this examiner's amendment was given in a telephone interview with Donald J. Daley (Reg. No. 34,313) on April 18, 2005.

The application has been amended as follows:

Cancel claims 10 and 12.

## Allowable Subject Matter

- 3. Claims 1-9 and 11 are allowed.
- 4. The following is an examiner's statement of reasons for allowance:

Claims 1-4 and 6-11 are allowed because prior art fails to teach or make obvious a method for calibration of a transformation of at least two X-ray attenuation values determined using different X-ray spectra for a material to a value for the density and a value for the atomic number of the material, the method comprising: determining a discrepancy between the determined values and the actual density and atomic number of a calibration sample; and using the discrepancy as the basis to produce a mapping rule which changes the values determined by the density function and the atomic

number function to the actual values as claimed in claim 1. Claims 2-4 and 6-12 are allowed by virtue of their dependence.

Claim 5 is allowed because prior art fails to teach or make obvious a computer program product for calibration of a transformation of at least two X-ray attenuation values, determined using different X-ray spectra, for a material, the computer program product, when run on a computer, causing the computer to perform the following steps: calculating a discrepancy between the values for the density and atomic number calculated for a calibration sample and the actual density and atomic number of the calibration sample; and producing a mapping rule which changes the values determined by the density function and the atomic number function to the actual values based on the discrepancy determined as claimed in claim 5.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

## Conclusion

5. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Spitz et al (US Patent 6,362,471 B1), Adriaansz (US Patent 6,574,302 B2), Siffert et al. (US Patent 6,570,955 B1) and Suess et al. (US Patent 6,490,336 B1) teach methods and apparatus for determining a density of a volume in the image data sets with the calibration phantoms.

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4. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Irakli Kiknadze whose telephone number is 571-272-2493. The examiner can normally be reached on 9:00- 5:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Ed Glick can be reached on 571-272-2490. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Irakli Kiknadze April 18, 2005

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SUPERVISORY PATERY EXAMINER